Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/825,342	EIB ET AL.	
Examiner	Art Unit	
Daborah Chacko-Davis	1756	

	SEARCHED					
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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Updated interference-see updated search history print out		5/8/2007	DCD	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
(430/311,322) updated text search only-see updated search history print out	5/8/2007	DCD
EAST (US-PGPUB, USPAT, FPRS, EPO, JPO, DERWENT, IBM-TDB) See updated search history print out	5/8/2007	DCD
Updated search history print out	5/8/2007	DCD
Updated eDAN inventor search	5/8/2007	DCD
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